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Concerning accuracy, there are many books on TEM which contain fundamental errors in understanding. This book, on the other hand, is reliable and accurate and reflects the scholarship one expects from Professor *Reimer*.

The book is for research students, post-doctoral scientists, lecturers and professors. It is good for teaching purposes and for reference. If you are an electron microscopist this book is the best: you should have it on your book shelves: I cannot recommend it too strongly.

C. J. Humphreys
Department of Materials Science and Engineering
The University of Liverpool
P.O. Box 147, Liverpool L69 3BX (UK)

Methods of Surface Analysis. Edited by J. M. Walls. Cambridge University Press, Cambridge 1989. x, 342 pages, bound, \$80.—ISBN 0-521-30564-0

At present, surface analysis and related methods represent one of the fastest progressing technological fields. Therefore there is an increasing demand for appropriate books, introducing the newcomer to the principles of these methods and their range of applications.

The above mentioned book is a compendium of articles from experts who cover one method or one field of interest each. The book contains 9 chapters dealing with the 6 most common methods of surface analysis (AES, XPS, SSIMS, DSIMS, ISS, RBS) and 3 more general topics which aim at supplying the reader with the essential basic knowledge. This selection out of the large number of different surface analysis techniques is wise and concentrates on those methods with a broad range of applications. Three more methods are briefly dealt with: Sputtered Neutral Mass Spectrometry (SNMS), Laser Microprobe Analysis (LIMA) and Atom Probe Microanalysis.

The book is composed well, contains instructive drawings and images, but mainly deals with VG products, almost neglecting all other products, instrument manufactures and construction principles. There is, for example, in the chapter "State-of-the-art XPS" only a short remark about small spot ESCA and no reference to the SSL instrument and the new Uppsala machine, the XPS "jumbo" ESCA-300. Also the world's finest scanning SIMS instrument, built by Levi-Setti in Chicago, is not mentioned at all. The spatial resolution in Scanning Auger Microanalysis is about 350 Å with commercially available instruments (e.g. PHI-660) and not 2000 Å as stated in Chapter 1.

The more practically oriented analyst, who has to struggle with the tricky every-day samples, would like to find some more examples of typical applications in the many fields in which surface analytical instruments are used today. In addition, the sections on data processing and curve fitting are very brief and confined to a list of possible computer routines. More information would have been helpful.

If there are many authors, who contribute to a book, it is obviously always difficult to make it up in such a way, that

everything fits together, that each writer uses the same formulas and expressions and that unnecessary repetition is avoided. The reviewer is of the opinion that these problems have been solved satisfactory.

Generally only few literature references are given, in some cases even too few, and they are often not mentioned in the text.

The book can be recommended without reservations for all VG instrument users and those being non-specialists, who are looking for an introduction into those surface analytical methods which are frequently used today, and who want to get information quickly on the appropriate technique to choose for a special applicational purpose.

Harald Hantsche Bundesanstalt für Materialforschung u. -prüfung Unter den Eichen 44–46, 1000 Berlin 45 (West)

Nuclear Magnetic Resonance, Vol. 18, Edited by G. A. Webb. Royal Society of Chemistry, Cambridge 1989. LVI, 511 pp., bound, \$ 232.-, ISBN 0-85186-412-0.

The number of applications of nuclear magnetic resonance (NMR) spectroscopy is growing rapidly and NMR is increasingly used also in non-traditional areas of application like the investigation of solid and macromolecular materials. To a considerable degree its increasing popularity is a result of the continuing development of innovative methods and measurement procedures for instance in solid state and two-dimensional NMR. A comprehensive literature review about current NMR activities can be of value not only for the specialist but also for those interested in the applicational potential of the method.

The book reviews the NMR literature published between June 1987 (1986 in some cases) and May 1988. The 13 chapters cover different subjects, which are reviewed by specialists. The individual chapters are preceded by a compilation of citations of 588 books and reviews. For this list, a subdivision into type of publication (books, regular review series, reviews in periodicals, etc.) has been chosen and not a classification according to subjects. Considering that there are references to reviews in each chapter on individual subjects the list seems redundant.

Chapter 1 (C. J. Jameson) covers the theory and physics of chemical shielding tensor values. Known as chemical shift in isotropic liquids, these values are essential for quantitative structural and dynamic solid state NMR. Chapter 2 (M. J. Foster) deals with the applications of nuclear shielding. Apart from ¹H and ¹³C, chemical shift studies of nuclei such as ⁶Li, ⁹Be, ^{14,15}N, ¹⁷O, ¹⁹F, etc. are reported. Spin-spin couplings are treated in Chapters 3 (theory: J. Ostershede) and 4 (applications: J. C. Lindon and J. M. Williams). Like the chemical shift values, the coupling constants give important information on molecular conformation. Different liquid state NMR techniques for their measurement as well as coupling between particular nuclei other than ¹H and ¹³C

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are reviewed. Chapter 5 (H. Weingärtner) is on nuclear spin relaxation in liquids and gases. Relaxation time studies which give information about molecular dynamics and molecular distance determination in biological macromolecules are included. Chapter 6 (R. Dupree) reviews solid state NMR. The chapter is subdivided into new techniques, theory, experimental, and several sections on different substances and areas of application like silicates, zeolites, ceramics, phase transitions, glasses, organic and inorganic solids, wood and coal. A number of tables efficiently guide the reader through the literature. Chapter 7 (L. Y. Lian) is entitled "Multiple Pulse NMR", a terminus technicus from solid state NMR, but deals with multi-dimensional NMR in liquids including the development of special excitation pulses. Chapter 8 (D. B. Davies and H. G. Parkes) surveys natural macromolecules, excluding biological studies, with many tables in the text. Chapter 9 (F. Hatley) reviews synthetic macromolecules, again largely in appealing tabular form. References to reviews are followed by sections on solution NMR studies of polymer structure by 1D and 2D NMR, polymer-polymer interaction in solution and gels, and on bulk polymers. The last section is subdivided into wideline ¹H NMR, high resolution NMR, NMR of deuterons and other nuclei, and applications to cellulose polymers. Relaxation and lineshape studies for the investigation of polymer dynamics are included as well as new magic angle spinning and cross-polarization techniques for the investigation of molecular order and polymer morphology. Chapter 10 (C. Jones) is dedicated to conformational analysis in liquid state NMR based on the measurement of indirect couplings, distance determination by cross-relaxation, and computer refinement. Chapter 11 (P. G. Morris) is concerned with NMR of living systems with subsections on NMR imaging and high resolution NMR. Chapter 12 (K. G. Orrell) treats NMR of paramagnetic species and Chapter 13 (A. Khan) NMR of liquid crystals and micellar solutions. The latter starts with a helpful introduction to the subject, which is missing in many of the other chapters. The smaller part of the material (4 pages) covers thermotropic liquid crystals, where solid state deuteron NMR is increasingly used for investigations of molecular order and mobility. The larger part (17 pages) deals with micellar solutions and lyotropic liquid crystals. Phase diagrams and phase structures in complex amphiphilic systems are investigated as well as multicomponent self-diffusion coefficients. Solid state NMR is applied more and more for studies of lipids and protein-lipid interactions

The readability of the chapters is adequate and the chapters cover the subjects in sufficient depth to gain an understanding of the current state of research. The use of tables in some chapters (1, 6, 8, 9, 12) provides quick and easy access to the information and should be encouraged in future volumes. A list of symbols and an author index are helpful features. For materials science oriented NMR research, chapters 1, 6, 9 and 13 are most relevant. The book is in competition with review papers and computer literature searches on dedicated subjects. Considering also the price, the book is unlikely to be found in every science library.

Bernhard Blümich Max-Planck-Institut für Polymerforschung Postfach 31 48, D-6500 Mainz (FRG)

Conference Calendar

The black hand symbol denotes new entries into the calendar. Send information concerning conferences to the editorial office.

January 1990

10-14 Superconductivity
Int. Conf.
Bangalore (India)
Contact: Prof. S. V. Subramanyam, ICSC, Dept. of
Physics, Indian Inst. of Sci.,
Bangalore 560012, India,
Tel. 91-812-344411,
Fax 91-812-341683

14-19 Electro-Optics

Conf.
Los Angeles, CA (USA)
Contact: SPIE, POB 10,
Bellingham, Wa 98227-0010,
USA, Tel. 206-676-3290,
Fax 206-647-14445

15-18 Advances in Composite Materials

Int. Conf.
Bombay (India)
Contact: Prof. P. Ramakrishnan, Indian Inst. of Techn.,
Dept. of Metallurg. Eng.,
Poway, Bombay 400076,
India

21-24 Gallium Arsenide

Symp.
Atlanta, GA (USA)
Contact: K. J. Sieger, Naval
Res. Lab., Code 6852,
Washington, DC 20375, USA

22-26 Recrystallization in Metallic Materials

Int. Conf.
Wollongong (Australia)
Contact: T. Chandra, Dept. of
Metallurgy and Materials Eng.,
Univ. of Wollongong, Wollongong NSW 2500, Australia,
Tel. 042-270008,
Fax 042-270477